

AUDIX Technology (Shenzhen) Co., Ltd. No. 6, Kefeng Road, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China Tel: 0755-26639495~6-7 Fax: 0755-26632877

Technical Compliance

No. ACS-E20225

The following product has been tested by us with the listed standards and found in compliance with the council EMC directive 2014/30/EU. It is demonstrative for the compliance with this EMC Directive.

Submitter : TPV Electronics (FuJian) Co., Ltd.

Rongqiao Economic and Technological Development Zone, Fuqing

City, Fujian Province, P.R. China

Product : LCD Monitor

Model No. : PVN-5501D*; PN-55H*; PN-55D*; PVN-5501H*

Brand : AG neovo

	Test Standards:		
EN 55032: 2012+AC:2013 (Class A) EN 55032: 2015 EN 55032: 2015+AC: 2016 CISPR 32: 2012 CISPR32:2015/COR1:2016 AS/NZS CISPR32:2015	Electromagnetic compatibility of multimedia equipment - Emission requirements		
EN 61000-3-2: 2014	Electromagnetic Compatibility(EMC) Part 3-2:Limits-Limits for harmonic current emissions(equipment input current ≤16A per phase)		
EN 61000-3-3: 2013	Electromagnetic Compatibility(EMC) Part 3-3:Limits-Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16A per phase and not subject to conditional connection		
EN 55035: 2017	Electromagnetic compatibility of multimedia equipment — Immunity requirements		
	IEC 61000-4-2: 2008	Electrostatic Discharge	
	IEC 61000-4-3: 2010	RF Field Strength Susceptibility	
	IEC 61000-4-4: 2012	Electrical Fast Transients	
	IEC 61000-4-5: 2014	Surge	
	IEC 61000-4-6: 2013	Continuous Conducted disturbance	
	IEC 61000-4-8: 2009	Magnetic Field Immunity	
	IEC 61000-4-11: 2004 IEC 61000-4-11: 2004+ AD 2019	お	

Audix Technology (Shenzhen) Co., Ltd.

EMC部門報告專用章

Stamp only for EMC Dept. Report

ignatureemm

Bensun Chen Manager

Date: Oct.16, 2020

The technical compliance is based on a single evaluation of one sample of above mentioned product. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.